То	Digi — Key	Issue No.		EZJ-30409		
	Date of Issue	:	${\tt November}$	12. 2002		
		Classification				

PRODUCT SPECIFICATION FOR INFORMATION

	*************	November 11.2007 from the date of issue
	I	For other applications contact our person signed below.
Applications	:	
Classification of S	pec :	SPECIFICATION
		EZJZSV270DAK
Product Part Number	:	EZJZSV270CAK
Product Description	•••••	MULTILAYER VARISTOR CHIP TYPE (ZnO)

When either your company or our company has no offer by document until three months before the termination of the validity date mentioned in this specification, the validity date of this specification shall be continuously extended one more year every year.

In addition to the above, if revision is performed during effective term and you have confirmed, old specification shall be invalidity.

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Ceramic Business Unit LCR Device Company

Matsushita Electronic Components Co., Ltd.

〒571-8506 1006 Kadoma, Osaka, Japan

Tel: Osaka (06) 6908-1101 Fax: Osaka (06) 6908-7735 Prepared by : Engineering Section

Contact Person:

Title: Engineer

Authorized by : +

Title: Manager of Engineering

·This product has not been manufactured with any ozone depleting chemical controlled under the Montreal Protocol.

- All the materials used in this part contain no browniated materials of PBBOs or PBBs as the flame retardant.
- All the materials used in this part are registered material under the Law Concerning the Examination and Regulation of Manufacture, etc. of Chemical Substances.

CLA	SSIFICATION	SI	PECIFICATION	 	REF. No
PRC	DDUCT MUI		YPE (Zinc Oxide)	151S-EZJZ-S-270CAK	
PART NUMBER E			EZJZSV270CAK		1-1
	Item		Requirements	Test Sp	ecifications
1.Str	ructure		•		
1.1	Appearance	Without	dirt and crack	T	
1.2		L	1.37 ± 0.15		!
		W	1.00 ± 0.15		
		T	0.66 max.	BW1	W
		BW	0.36 ± 0.10		
		BW1	0.20 ± 0.10	1	
		P	0.64 ± 0.10]	
			unit:mm	1	L
				BW	
				─	◆ !!!
					A A
					T
					P
2.Ele	ectrical Requirements				
2.1	Maximum allowable voltage		DC 16 V		
2.2	Varistor voltage		27V ± 15%	Measuring current	DC 1mA
2.3	Capacitance		22pF ± 10%.	Measuring voltage Measuring frequency	1.0 Vrms.
-					
2.4	Clamping voltage		50 Vmax.	Impulse waveform	8/20 μ s
	1 0 0			Impulse current	1A
				Impulse waveform	8/20 μ s
2.5	Maximum peak current		5A	Repetition times	2 times
	•			Repetition times	
					(5 minutes interval)
Note	:				
	DATE			APPROVAL	CHECK DESIGN
					. DESIGN
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CLASSIFICATION SPECIFICATION REF. No					
PRODUCT MULTILAYER VARISTOR CHIP T			YPE (Zinc Oxide)	151S-EZJZ-S-270DAK	
PART NUMBER EZJZSV270DAK				1-1	
	Item		Test Spe	ecifications	
1.Str	ucture				
1.1	Appearance	Without	dirt and crack		
1.2	Dimensions	L	1.37 ± 0.15		
		W	1.00 ± 0.15		
		T	0.66 max.	BW1	W
		BW	0.36 ± 0.10		
		BW1	0.20 ± 0.10	1	
		P	0.64 ± 0.10		
			unit:mm		L
				BW	
					<u> </u>
	,				
	1				
				-	
				1	P
2.Ele	ectrical Requirements				
2.1	Maximum allowable		DC 16 V		
	voltage		DC 10 V		
2.2	Varistor voltage		$27V \pm 15\%$	Measuring current	DC 1mA
2.3	Capacitance		$27pF \pm 10\%$.	Measuring voltage	1.0 Vrms.
				Measuring frequency	1MHz
				Impulse waveform	8/20 μ s
2.4	Clamping voltage		50 Vmax.	Impulse current	1A
-					
				Impulse waveform	8/20 μ s
2.5	Maximum peak current		5A	Repetition times	2 times
					(5 minutes interval)
Note					
					:
	DATE				CHECK DESIGN
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CLA	SSIFICATION	SPECIFICATION	ON	JREF. No.
PRODUCT		MULTILAYER VARISTOR CH	151S-EZJZ-S-C01	
PART NUMBER		COMMON SPESIFI	CATION	6 - 1
	Item	Requirements	Test Specific	ations
3.M	echanical Requirements			
3.1	Substrate bending	Without mechanical damage	Bending stress 2mm Bending speed 1.0mm/sec.	
			Hold time 5sec.	
3.2	Solderability	Approximately 75% of the termi- nals shall be covered with new	Solder temp. 230±5°C Dipping period 4±1 sec.	
		solder uniformly		
3.3	Resistance to	Without mechanical damage	Solder temp. 270±5°C	
	soldering heat	ΔV+lmA≦±10%	Dipping period 3.0±0.5 sec.	
4 E	nviromental Requirements		[Dipping period 3.020.3 sec.	·- ·······
4.1	Temperature cycle	Without mechanical damage ΔV+1mA≤±10%	Cycles 5 cycles Step Temperature Pe	eriod
				min
			2 Room temp. 5	min.
			3 85±5℃ 30	min.
			4 Room temp. 5	min.
4.2	Damp heat load	ΔV+lmA≦±10%		90~95%RH owable voltage h
4.3	Dry heat load	ΔV+lmA≦±10%	Ambient condition 85±5°C	
			Applied voltage Max.allo	owable voltage
			Test period 500+24 - 0	h
0	perating temperature range		-40 to 85 C	
Note			:	
	DATE		APPROVAL C	CHECK DESIGN
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CLASS	SIFICATION		SPECIFICATION	No.			
SUBJECT			MULTILAYER VARISTOR CHIP TYPE (Zinc Oxide) TEST METHOD (COMMON SPECIFICATION)	151S-EZJZ-S-C01 6 - 2			
Characteristics		tios	Test Method	0 - 2			
	Standard test co		Unless otherwise specified all test and measurements shall be made at	a temperature			
	Standard test ec	mannon	of 15~35°C and at a relative humidity of 45~75%RH.	a temperature			
			If results obtained are doubted a further test should becarried out at a to	emperature of			
			$20\pm2^{\circ}$ C and a relative humidity of $60\sim70\%$ RH.	simperature or			
2 E14			2022 C and a remain of manually of our properties				
	rical requireme						
2.1	Max.allowab	ole	The maximum DC voltage that can be applied continuously in the spec	ified operating			
	voltage		temperature.				
2.2	Varistor volt	age	The voltage between two terminals with the specified measuring curre	nt 1mA DC			
			applied is called V1mA.				
			The measurement shall be made as fast as possible to avoid heat affect	ion.			
2.3	Capacitance		Capacitance shall be measured at 1MHz±10%,0.2~2.0Vrms.,0V bias	and 25°C.			
2.4	Clamping vo	ltage	The maximum voltage between two terminals with the specified standard impulse				
			$\operatorname{current}(8/20\mu\mathrm{s})$.				
2.5	Maximum po	eak current	The maximum current within the varistor voltage change of ±10% when a standard				
			impulse current of $8/20 \mu s$ is spplied two times with an interval of 5 minutes.				
2.6	Maximum E	The maximum ESD within the varistor voltage change of $\pm 30\%$ when a stand					
			impulse ESD is applied.				
			* ESD : Electrostatic Discharge				
				-			
Note:	1		l				

CLASSIFICATION			SPECIFICATION	No.			
SU	JBJECT		MULTILAYER VARISTOR CHIP TYPE (Zinc Oxide) TEST METHOD (COMMON SPECIFICATION)	151S-EZJZ-S-C01 6 - 3			
Characteristics			Test Method				
3. Mech	3. Mechanical requirements						
3.1	Substrate be		After soldering specimen on the substrate, 2mm of bending shall				
			be applied . Bending speed : 0.5mm/s .				
3.2	Solderability	y	Dip the specimen in solder so that both terminals electrodes are compl	•			
			submerged. Use solder H63A(JIS -Z-3282). For the flux, about 25%	by weight.			
			Use tweezer for the holder to dip the specimen.				
3.3	Resistance t	0	Dip the specimen in molten solder so that both terminals electrodes are	completely			
	soldering he	at	submerged. Before dipping preheat the specimen according to the table	le below.			
			After test, the specimen shall be left to stand at room temperature for 2	24±2 hours.			
			The change of V1mA and mechanical damage shall be examined.				
4. Envir	omental requi	rements					
4.1	Temperature	e cycle	Solder the specimen to the testing jig. Condition the spesimen to each	n temperature			
			from step 1 to 4 in this order for the period shown in the table of specia	fications.			
			Before the measurement after test, the specimen shall be left to stand a	at room			
			temperature for 24±2 hours. The change of V1mA and mechanical da	mage shall be			
			examined.				
4.2	Damp heat l	oad	Solder the specimen to the testing jig. The specimen shall be applied c	ontinuously			
			the Maximum allowable voltage at apecified conditions for specified p	-			
			stored at room temperature and normal humidity for 24±2 hours.				
			Thereafter, the change of V1mA and mechanical damage shall be example.	mined			
4.3	Dry heat loa	d	Solder the specimen to the testing jig. The specimen shall be applied of				
4.5	Dry neat roa	.u	the Maximum allowable voltage at apecified conditions for specified p	·			
				eriod and then			
			stored at room temperature and normal humidity for 24±2 hours.				
			Thereafter, the change of V1mA and mechanical damage shall be example to the change of V1mA and mechanical damage shall be example.	ninea.			
Note:							

CLASSIFICATION	SPECIFICATION	No.
SUBJECT	MULTILAYER VARISTOR CHIP TYPE (Zinc Oxide)	151S-EZJZ-S-C01
	TAPED AND REELED PACKAGE SPECIFICATION (COMMON SPECIFICATION)	6 - 4

1. Scope

This specification applies to the taped and reeled packaging for 'MULTILAYER VARISTOR CHIP TYPE (Zinc Oxide)'.

2. Applicable standars

EIAJ (Electric industories assosiation of japan) Standard EIAJ RC-1009B

JIS (Japanese Industrial standard) Standard JIS 0806

3. Packing specificaton

3.1 Structure and dimensions

(1)Carrier tape: Shown in Fig,1(2)Reel: Shown in Fig,2

(3)Packaging : We shall pack suitable in order to prevent damage during transportation

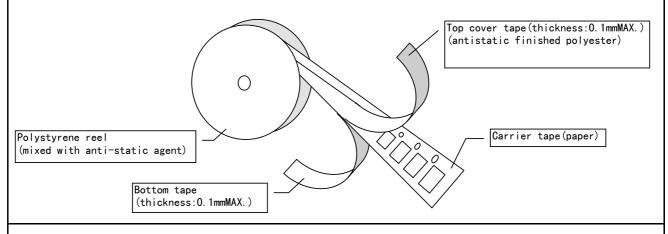
or storage.

3.2 Packing Quantity

Туре	Quantity (pcs./reel)
2 array	4000

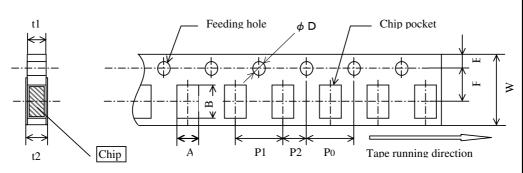
3.3 Structure of taping

(1) The direction of winding of taping on the reel shall be in accordance with the following diagram.



LASSIFICATION	SPECIFICATION	No.
SUBJECT	MULTILAYER VARISTOR CHIP TYPE (Zinc Oxide)	151S-EZJZ-S-C01
	TAPED AND REELED PACKAGE SPECIFICATION (COMMON SPECIFICATION)	6 - 5
(2)Th	e specification of the leader and empty portion shall be in accordance with the following	ng diagram.
	Vacant position Components Vacant position Vacant position	Leader part (cover tape)
m 1		
Tape end		
	40mm min. 40mm min.	> 200mm min.
	(10 pich) 40mm min. (10 pich)	200mm min.
	Tape running direction	
3.4 Mark	ing on the reel	
On th	e side of the reel we shall indicate no fewer than the items.	
(1)Pa	rt number	
(2)Qu	antity	
(3)Lo	t number	
4. Efficiency		
4.1 Break	age strength of the tape	
1.0 N	(approx.1 kgf) or more.	
4.2 Peel s	strength of the tape (refer to the following figure).	
(1)Pe	el angle : 165 to 180 degree from the tape adhesive face.	
(2)Pe	el velocity : 300 mm per min.	
(3)Pe	el strength : 0.1 to 0.7 N (approx. 10 to 70 gf).	
	Cover tape peeling direct	ion
	Carrier tape	
4.3 Barrs	·	
	shall be no barrs proventing section when products are taken out.	
	ng of products	
	nissing of products shall be 0.1% or less per reel and there shall be no continuous	
	ng of products	
	rence to the tape	
	icts shall be not be stuck to the cover tape or bottom tape.	



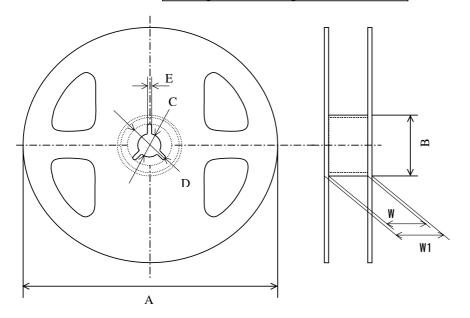


Code	Dimension		
W	8.0±0.2		
F	3.50±0.05		
Е	1.75±0.10		
P0	4.0±0.1		
P1	4.0±0.1		
P2	2.00±0.05		
D0	$\phi 1.5 \begin{array}{c} +0.1 \\ -0 \end{array}$		

(unit:mm)

Code	Dimension
A	1.18 ± 0.05
В	1.63 ± 0.05
t1	1.1 max.
t2	1.4 max.

Fig.1 Carrier tape dimension



Code	Dimension
A	φ 180 +0 -3. 0
В	φ 60±0.5
C	13.0±0.5
D	21.0±0.8
Е	2.0±0.5
W	9.0±0.3
W1	11.4±1.0

(unit:mm)

Fig.2 Reel Dimension

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SUBJECT	MULTILAYER VARISTOR CHIP TYPE (Zinc Oxide)	151S-EZJZ-C04-R01
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Precautions for Safety

The Multilayer Varistor (hereafter referred to as "The Varistors") may fail in a short circuit mode on in an open-circuit mode, when subjected to severe conditions of electrical, environmental and/or mechanical stresses beyond the specified "Ratings" and specified "Conditions" in the Catalog and the Specifications, resulting in burnout, flaming or glowing in the worst case.

Following "Precautions for Safety" and "Application Notes" shall be taken in your major consideration. If you tyr to apply our product for the following electronic equipments, or have any question, Please contact us.

- Aitificial satellite, cosmic rocket
- Aircraft
- Seabed repeater
- •Traffic/transport system(automobil,aircraft,rolling stock,ship,traffic signal control equipment)
- Electric power plant(nuclear power,thermal power,hydraulic power generation)
- Medical equipment
- Information processing system
- •Seculity system
- Rotating machine
- 1. Operating Conditions and Circuit Design
 - (1) The Varistors shall not be operated beyond the specified "Ratings" and "Environmental Conditions" in the Catalog or the Specifications to prevent them from deterioration, brealdown, flaming
 - 1.1 The Varistors shall not be operated beyond the specified "Operating Temperature Range" in the Catalog or the Specifications.
 - 1.2 The Varistors shall not be in "AC power circuit".
 - 1.3 The Varistors shall not be operated exceeding the specified "Maximum Allowable Voltage" in the Catalog or the Specification.
 - 1.4 The Varistors shall not be subjected to energy levels above their specified "Maximum energy Ratings" in the Catalog or the Specifications.
 - (2) The Varistors shall be operated correctly under following conditions to prevent Varistors from causing mechanical damages and ruptures and to protect human from serious injuries.
 - 2.1 The Varistors shall not be operated exceeding the specified "Maximum Allowable Voltage" in the Catalog or the Specification.
 - 2.2 The Varistors shall not be operated exceeding the specified "Maximum Peak Current Ratings" in the Catalog or the Specification.
 - (3) It is recommended that the Varistors, if not fused , shall not located away from other combustibe components.

Note:			

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2. Restriction on environmental conditions

The varistors shall not be operated and / or stored under following environmental conditions.

- (1) Environmental conditions
 - (a) To be exposed directly to water or salt water.
 - (b) Under conditions of dew formation.
 - (c) Under conditions of corrosive atmosphere such as hydrogen sulfide, sulfurous acid, chlorine or ammonia etc...
- (2) Under severe conditions of extreme vibrations or shocks.

3. Precautions for Printed-Circuit-Board Design

3.1 Selection of printed circuid board

When the varistors are mounted and soldered on an "Aluminum substrate", the substrate has infuluences on varistors reliabilities against "Temperature cycles" and "Heat shock" because of difference of thermal expansion coefficient between them. It shall be carefully confirmed that the actual board applied does not deteriorate the characteristics of the varistors.

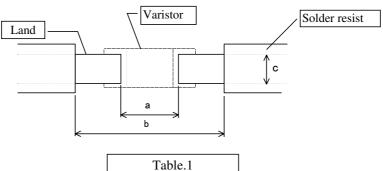
3.2 Design of land pattern

Recommended dimensions of lands; As shown in table 1 and Fig. 1

(1) If the land area is too large, the amount of solder will become so large that the cracks will occur in the varistor when soldering.

The land size shall be not exceed the varistor width.

Fig.1 Recommended land dimensions(Ex.)



(Unit:mm)

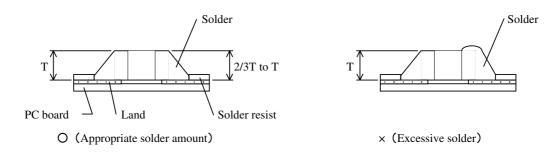
Type	Co	ompon	ent	Flow soldering			t Flow soldering Reflow soldering			ng
(size)	di	imensi	on							
	L	W	T	a	b	c	a	b	c	
0402(1005)	1.0	0.5	0.5	-	_	_	0.5 to 0.6	1.5 to 1.7	0.5 to 0.6	
0603(1608)	1.6	0.8	0.8	0.8 to 1.0	2.0 to 2.6	0.6 to 0.8	0.8 to 1.0	2.0 to 2.6	0.8 to 1.0	
0805(2012)	2.0	1.25	0.85	1.0 to 1.4	3.0 to 3.8	0.8 to 1.0	0.8 to 1.2	2.4 to 3.2	1.0 to 1.2	

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(2) The sizes of lands shall be equal between in the right half and in the left half are different, the half of which the amount of solder is larger than of the other is soldified later.

This may apply stress to one half and the cracks occur in the varistor.

Fig.2 Recommended solder amount



- (3) In the following conditions, the lands of varistor shall be divided other lands by solder resist. If there is no resist, amounts of solder will become so large that the cracks will occur in the varistor when soldering.
 - i) other chip components contact the varistor
 - ii) lead components are directly contacted to the varistor
 - iii) common lands (chassis,stc.) are close to the varistor

3.3 Components layout

When placing / mounting the varistor near an area which is apt to bend or a grid groove on bord, it is advisable to have both electrodes subjected to uniform stresses, or to position the varistors electrodes at right angles to the grid groove or bending line.

(1) Mounting density and spaces

Placements in too narrow spaces between components may cause "Solder Bridges", during soldering . The minimum space between components shall be 0.5mm in view of the positioning tolerances of the mounting machines and the dimensional tolerances of the components and PC boards.

- (2) Applications of solder resist are effective to prevent solder bridges and to control amounts of solder on PC boards.(As shown in Table 2)
 - (a) Solder resist shall be utilized to equalize the amounts of solder on both sides.
 - (b) If varistor of arranged in succession, and if they are mounted together with a component with a lead of positioned near a chassis etc., solder resist shall be used to divide the pattern.

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Table 2 Applications of Solder Resist

	Good Ex.	Bad Ex.
Two or more chip componnents contact each other.	Solder resist	
Lead components are directly connected to chip components.	Solder resist	
Common lands(chass is ,ets,) are close to chip components.	Solder resist	

4. Precautions for Mounting for assembly

4.1 Storage

- (1) Varistors shall not be stored under servers conditions of high temperature and humidity . Store them indoors under at 5 to 40° C or less and 20 to 70%RH or less.
- (2) If the storage place is humidity, dust, and contains corrosive gasses (hydrogen sulfide, sulfurous acid, hydrogen chioride and ammonia etc.), the solderability of the external electrode may be reduced. Storage in a place exposed to heat and direct sunlight causes deformation of the reels and tapes of tapepackaged products and adhesion of components to tapes, which results in troubles in case of mounting.
- (3) The period of storage not exceed 6 months. For products stored for more than 6 months, their solderability shall be checked before they are used.

4.2 Adhesives for mounting

- (1) The viscosity of a adhesive for mountings shall be such that the adhesive does not flow off on the land during it's curing.
- (2) If the adhesive is too low its viscosity, mounted components may be out alignment after or during soldering.
- (3) The adhesive shall not be corrosive or chemically active

Note:			

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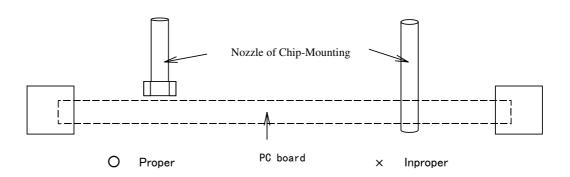
- (4) The amount of adhesive shall be such that the adhesive does not flow off or be out of alignment.
- (5) Adhesives for mountings can be cured by ultraviolet or infrared radiation. Inorder to prevent the terminal electrodes of the varistors from oxidizing. The curing shall be done at conditions of 160°C max., for 2 minutes max..

4.3 Chip mounting consideration

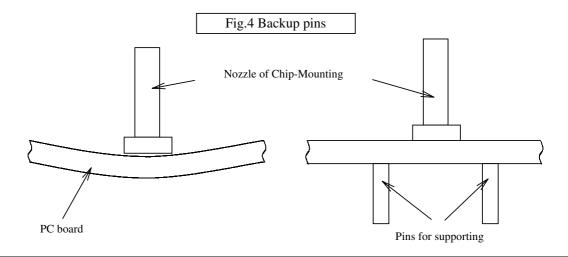
In mounting the varistors/components on a printed circuid board, /any bending and expanding force against them shall be kept minimum to prevent them from bending damaged or cracked.

- Following precautions and recommendations shall be observed carefully in the process.
- (1) Maximum stroke of the vacuum nozzle shall be adjusted so that the pushing force to the printed circuid board shall be limitted to a static load of 1 to 3N(100 to 300gf).
- (2) Maximum stroke of the nozzle shall be adjusted so that the maximum bending of printed circuit board does not exceed 0.5mm.

Fig.3 Bottom dead point height of the vacuum nozzle



(3) The printed circuit board shall be supported by means of adequate supporting pins.



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4.4 Soldering flux and solder

(1) Soldering flux

The content of halogen in the flux shall be 0.2wt% (Cl conversion) of less Rosin-based and non-activated soldering flux is recommended.

(2) Water soluble type soldering flux

In case of water soluble type soldering flux being applied, the flux residue on the surface of P.C. board may have influences on the reliability of the components and cause deterioration and failures of them.

(3) Solder

An eutectic solder (Sn:63,Pb:37) is recommended.

4.5 Soldering

4.5.1 Flow soldering

In flow soldering process, abnormal and large thermal and mechanical stresses, caused by "Temperature Gradient" between the mounted varistor and melted solder in a soldering bath, may be applied directly to the varistors, resulting in failures and damages of the varistors.

So it is esscential that soldering process shall be controlled to the following recommended conditions.

(1) Application of flux

The soldering flux shall be applied to the mounted varistor thinly and uniformly by forming method.

(2) Preheating

The mounted varistors/components shall be preheated sufficiently so that the "Temperature Gredient" between the varistors/components and the melted solder shall be 150°C or below.

(3) Immersion to soldering bath

The varistors shall be immersed into a soldering bath of 240 to 250°C for 3 to 5 seconds.

(4) Cooling

The varistor shall be cooled gradualy to room ambient temperature with the cooling temperature rates of $8 \,^{\circ}\text{C/s}$ max. from 250 to 170 $\,^{\circ}\text{C}$ and $4 \,^{\circ}\text{C/s}$ max. from 170 to 130 $\,^{\circ}\text{C}$.

(5) Flux cleaning

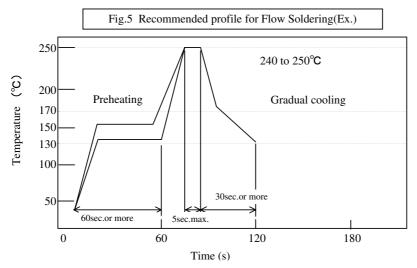
When the varistors are immersed into cleaning solvent, it shall be confirmed that the surface temperature of devices do not exceed 100° C.

(6) There is no problem with twice flow soldering under the conditions described in the diagram [Recommended Profile for Flow Soldering (Example)] below.

Care shall, however, be taken to prevent board warp or bend.

Note:			

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4.5.2 Reflow soldering

In reflow soldering process, the mounted varistors/components are generally heated and soldered by a thermal conduction system such as an "Infrared rediation and hot blast soldering system " or a "Vapour Phase Soldering System (VPS)". Large temperature gradients such as a rapid heating and cooling in the process may cause electrical failures and mechanical damages of the device.

It is essential that the soldering process shall be controlled by the following recommended conditions and precautions.(See Fig.6)

(1) Preheating 1

The mounted varistors/components shall be preheated sufficiently , for 60 to 90 seconds so that the surface temperatures of them to be 140 to 160° C .

(2) Preheating 2

After "Preheating 1", the mounted varistors/components shall be heated to the elevated temperatures of 150 to 200°C for 2 to 5 seconds.

(3) Soldering

The mounted varistors/components shall be heated under the specified heating conditions (200 to 240 to 200°C for total of 20 to 40 seconds, See Fig. 10) and shall be soldered at the maximum temperature of 240°C to 10 seconds or less.

(4) Cooling

After the soldering, the mounted varistors/components shall be granually cooled to room amnient temperature for preventing mechanical damages such as crackings of the devices.

(5) Flux Cleaning

When the varistors are immersed into cleaning solvent, it shall be confirmed that the surface temperature of devices do not exceed 100° C.

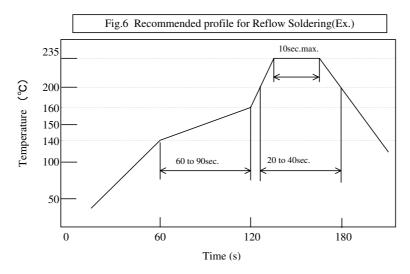
Note:			

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(6) There is no problem with twice flow soldering under the conditions described in the diagram [Recommended Profile for Flow Soldering(Example)] below.

Care shall ,however ,be taken to prevent board warp or bend.

Note: If the mounted varistors/components are partially heated in the soldering process, the devices may be separated from the printed circuit board by surface tension of partially melted solder, and stand up like a "Tomb stone".



4.5.3 Hand Soldering

In hand soldering of the varistors, large temperature gradient between preheated the varistors and the tip of soldering iron may cause electrical failures and mechanical damages such as crackings or breaking of the devices. The soldering shall be carefully controlled and carried out so that the temperature gradient is kept minimum with following recommended conditions for hand soldering.

(1) Solder

 ϕ 1mm Thresd euetic solder with soldering flux in the core.(Rosin-based,and non-sctivated flux is recommended)

(2) Preheating

The varistors shall be preheated so that "Temperature Gredient" between the devices and the tip of soldering iron is 150°C or below.

(3) Solder Iron

Rated Power of 20W max. with 3mm soldering iron tip in diameter.

- (4) Temperature of soldering iron tip; 300°C max.

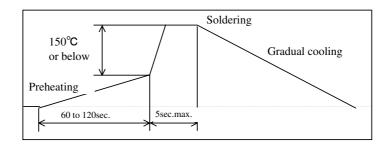
 (The required amount of solder shall be melted in advance on the soldering tip.)
- (5) Cooling

After the soldering, the varistors shall be cooled gradually at room ambient temperature.

Note:		

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Fig.7 Recommended Soldering by Hand Soldering(Ex.)



4.6 Post Soldering Cleaning

- (1) Residues of corrosive soldering fluxes on the PC board after cleaning may greatelly have influences on the electrical characteristics and the reliability (such as humidity resistance) of the varistors which have been mounted on the board, it shall be confirmed that the characteristics and the reliability of the devices are not affected by the applied cleaning conditions.
- (2) Solubility of alternative cleaning solvent such as alcohol etc., is inferior to that of freon cleaning solvent in the flux cleaning.
 - So in a case of alternative cleaning solvents applied, fresh cleaning solvent always shall be used, and sufficient rinsing and drying shall be carried out.
- (3) When an ultrasonic cleaning is applied to the mounted varistors on PC boards, following conditions are recommended for preventing failures or damages of ultrasonic waves.

Frequency; 29kHz max.

Period; 5 minutes max.

4.7 Process Inspection

When the surface of a printed board on which the varistors has been mouted is coated with resin to protect against moisture and dust, it shall be confirmed that the protective coat does not have influences on reliability of the varistors in the actual equipment.

- (1) Coating meterials, such as being corrosive and chemically active, shall not be applied to the varistors and other components.
- (2) Coating materials with large exansivity shall not be applied to the varistors for preventing failures or damages (such as crackings) of the devices in the curing process.

Note:		
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(1) Al on (2) Di	aviding / Breaking of PC Boards conormal and excessive mechanical stresses, such as bending or expanding force on the a the printed circuid board, shall be kept minimum in the dividing / breaking. Aviding / Breaking of the PC boards shall be done carefully at moderate speed by using apparatus to prevent the varistors on the boards from mechanical damages.	
5. Product pl	ace	
Hokkaido	Matsushita Electric Co.,Ltd. / 1037-2 , Kamiosatsu, Chitose-shi , Hokkaido , Japan	
Note:		